

Search Notes

Application/Control No.

10/612,615

Examiner

Tianjie Chen

Applicant(s)/Patent under
Reexamination

INOUE ET AL.

Art Unit

2656

SEARCHED

Class	Subclass	Date	Examiner
369	275.4		
	286		
	280		
	281		
	283	2/10/2006	TJ

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East Reports	2/10/2006	TJ